

<b>Notice of References Cited</b>	Application/Control No. 10/522,029		Applicant(s)/Patent Under Reexamination HAYASHI ET AL.	
	Examiner Timothy C. Vanoy		Art Unit 1754	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-3,761,570	09-1973	Lowicki et al.	423/225
*	B	US-6,156,283	12-2000	Allen et al.	423/219
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 53-087,972 A	08-1978	Japan	Nishino et al.	B01D 53/34
	O					
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	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	The English abstract of CN 1354686 A published on June 19, 2002.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.